

Search Notes**Application/Control No.**

10/649,472

Examiner

Kin-Chan Chen

Applicant(s)/Patent under Reexamination

CHENG ET AL.

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner
438	689	5-6-05	k-cc
	693		
	745		
	756		
438	757		
252	79.1		
252	79.4	5-6-05	k-cc

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Keywords search USPT, US PG-Publ EPO, JPO, TBM-TDB	5-6-05	k-cc
Derwent, Inventor search		
Peruse parent case 09/981, 436	5-6-05	k-cc